P2,7051.A02.DOC Customer No.: 44152

Attorney Docket No.: BUR920040050US1

AMENDMENT TO THE CLAIMS

This listing of claims is a copy of all pending claims, which identifies the status of each claims, and which replaces all prior versions, and listing of claims in the application.

Listing of Claims

1. (Original) A power clamp for an integrated circuit, comprising:

a transistor network connected between a voltage source and a ground;

a bias network configured to bias a gate of a first transistor of the transistor

network to a portion of a voltage value of the voltage source; and

a trigger network configured to communicate the occurrence of an electrostatic

discharge event to the gate of a second transistor of the transistor network.

2. (Original) The power clamp of claim 1, wherein the transistor network

comprises a first nFET and a second nFET connected in series with one another

between the voltage source and a ground.

3. (Original) The power clamp of claim 2, wherein the transistor network further

comprises a third nFET connected in series with the first nFET and the second nFET

between the voltage source and the ground.

4. (Currently amended) A The power clamp of claim 3, for an integrated circuit,

comprising:

P27051.A02.DOC

Attorney Docket No.: BUR920040050US1

a transistor network connected between a voltage source and a ground;

a bias network configured to bias a gate of a first transistor of the transistor

network to a portion of a voltage value of the voltage source; and

Customer No.: 44152

a trigger network configured to communicate the occurrence of an electrostatic discharge event to the gate of a second transistor of the transistor network,

wherein the transistor network comprises a first nFET and a second nFET connected in series with one another between the voltage source and a ground,

wherein the transistor network further comprises a third nFET connected in series with the first nFET and the second nFET between the voltage source and the ground, and

wherein the bias network further comprises a voltage divider configured to communicate a portion of the voltage from the voltage source to the gate of the first transistor and a gate of the third nFET.

- 5. (Original) The power clamp of claim 1, wherein the bias network comprises a voltage divider configured to communicate a portion of the voltage from the voltage source to the gate of the first transistor.
- 6. (Original) The power clamp of claim 1, wherein the trigger network comprises a resistor and a capacitor configured to filter out non-electrostatic discharge events from the gate of the second transistor.
 - 7. (Original) A power clamp for an integrated circuit, comprising:

P27051.A02.DOC Customer No.: 44152

Attorney Docket No.: BUR920040050US1

at least an upper and a lower nFET connected in series with one another between a pair of power supply rails;

a voltage divider configured to bias a gate of the upper nFET to a prescribed value; and

a low frequency filter connected to a gate of the lower nFET and configured to filter out low frequency signals between at least one power supply rail and the gate of the lower nFET.

- 8. (Original) The power clamp of claim 7, wherein the gate of the upper nFET is biased to a prescribed fraction of a voltage between the pair of power supply rails.
- 9. (Previously presented) The power clamp of claim 7, wherein the voltage divider is connected between the pair of power supply rails and comprises at least one bias network.
- 10. (Original) The power clamp of claim 9, wherein the voltage divider comprises at least one resistor.
- 11. (Original) The power clamp of claim 7, wherein the low frequency filter communicates with a source and a drain of the lower nFET.
- 12. (Original) A method of protecting against electrostatic discharge, comprising:

P27051.A02.DOC Customer No.: 44152

Attorney Docket No.: BUR920040050US1

configuring a gate of at least one upper transistor of a transistor network connected between power rails to be biased to a prescribed value; and

coupling an electrostatic discharge event to a gate of a lower transistor of the transistor network.

- 13. (Original) The method of claim 12, further comprising biasing the gate of the at least one upper transistor with a voltage divider connected between the power rails.
- 14. (Previously presented) The method of claim 12, further comprising configuring the voltage divider to comprise at least one bias network.
- 15. (Original) The method of claim 14, further comprising biasing the gate of the at least one upper transistor to a prescribed fraction of the voltage of at least one power rail of the power rails.
- 16. (Original) The method of claim 12, wherein configuring a gate of at least one upper transistor of a transistor network connected between power rails to be biased to a prescribed value comprises applying a voltage to at least one power rail of the power rails.
- 17. (Original) The method of claim 12, wherein configuring a gate of at least one upper transistor of a transistor network connected between power rails to be biased to a prescribed value comprises attaching a bias network between at least one power

P27051.A02.DOC

Attorney Docket No.: BUR920040050US1

rail of the power rails and the transistor network.

18. (Original) The method of claim 12, further comprising coupling an electrostatic discharge event to a gate of a lower transistor with a high pass filter.

Customer No.: 44152

- 19. (Original) The method of claim 18, further comprising configuring the high pass filter to comprise a time constant of about one microsecond.
- 20. (Original) The method of claim 12, further comprising configuring at least one power rail of the power rails to be in electrical communication with a voltage source, and configuring at least one power rail of the power rails to be in electrical communication with ground.